



IBM POUGHKEEPSIE

# Diagnostic Engineering Publication

1410/7010

December 1, 1963

Subject: Diagnostic Program WT01B 1415 I/O Printer Test  
Sequence Number 551  
Replaces WT01A

When WT01 is in card form card # 001 is a System Control Card. It does not have any control information punched in it when it is released.

Refer to "1410/7010 Introduction", Volume 1.00 for instructions on how it must be punched.

This is a modified and improved version of WT01A. The modifications include:

- A. Changes necessary to be compatible with the current diagnostic format.
- B. Removal of the test routine called "WMS AND BLANKS IN M & L MODES."
- C. Alteration and expansion of the test routine called "WM ALIGNMENT AND WM PERIOD TESTS."
- D. Inclusion of a new test routine to check on band width (detenting difference) and alignment.
- E. Changing the timing section to type out the time it took to type each line instead of each pair of lines. The timing routine (now) covers 7010 as well as 1410 systems.
- F. Changing the method in which the optional "SELECTED CHARACTER ROUTINE" (build your own test pattern routine) operates.

Enclosures: 26 Pages  
Card Deck for CARD ONLY SYSTEMS (as punched by UP51)  
8 Cards - Card Loader (1-7) and 1 Core Clear  
62 Cards No. 001-062 Data Cards  
1 Card Execute Card

Distribution: X 1410  
X 7010  
Other



WT01

1415 CONSOLE I/O PRINTER TEST

(1410/7010)

December 1, 1963

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5.00.00.0 TEST DESCRIPTION

00.1 MODIFICATIONS

This is a modified and improved version of WT01A. The modifications include:

- A. Changes necessary to be compatible with the current diagnostic format. (Standard TADs at location 01000 and a Standard System Control Card to provide necessary system information and eliminate unnecessary operator intervention.)
- B. Removal of the test routine called "WMS AND BLANKS IN M & L MODES." This test routine contributed little to the overall effectiveness of the test.
- C. Alteration and expansion of the test routine called "WM ALIGNMENT AND WM PERIOD TESTS." See description, Section 5.00.00.2, for further information.
- D. Inclusion of a new test routine to check on band width (detenting difference) and alignment.
- E. Changing the timing section to type out the time it took to type each line instead of each pair of lines. The timing routine (now) covers 7010 as well as 1410 systems.
- F. Changing the method in which the optional "SELECTED CHARACTER ROUTINE" (build your own test pattern routine) operates. See OPERATING PROCEDURES, Section 5.00.02.2.

00.2 DESCRIPTION

WT01 is a functional test of the Program Printout Operations of the 1415 Console I/O Printer on the 1410 or 7010 Data Processing System. Test routines are directed toward checking Character Printout, Space, Word-Mark Control, and Carriage Return and Indexing Operations. The Input Operation is tested through the use of the Console Inquiry function.

5.00.00.0 TEST DESCRIPTION (continued)

Test patterns are designed to test specific operations or phases of operations. Before each pattern is typed, the title of the test pattern selection character is typed (see Section 5.00.02.2 for use of test pattern selection character).

The test patterns, their titles and test objectives are explained in the order in which they are run. Each test line of characters is typed twice for (visual) comparison.

**COLLATING SEQUENCE** A

Type all characters in the COLLATING SEQUENCE for convenient visual checking.

**ROCK** B

Test the tilt mechanism by typing the characters located one after the other in vertical columns on the print head.

**ROLL** C

Test the rotate mechanism by selecting characters one after the other in horizontal bands around the print head.

**TWIST** D

Test the combined rotate and tilt mechanism by causing a maximum rotation and tilt between characters.

**WM ALIGNMENT AND WM PERIOD TESTS** E

Exercise thoroughly spacing and backspacing mechanisms by typing word marks over every other character and then over every character. The word-mark period latch is given specific attention here.

**BANDWIDTH & ALIGNMENT TEST** F

The characters typed are chosen specifically to test band width (detenting difference), alignment and the action of the wear compensator. The characters, \$!QNLJ, are chosen because of their rotate selections. If a band width exists, it will be greatest among these characters. They are also used in a final check during alignment (fine tuning). The "J" is used extensively to cause the wear compensator to take up slack in the rotate and select system.

5.00.00.0 TEST DESCRIPTION (continued)

All test pattern selection characters should line up in position 42 on the margin scale as a test of the spacing operation.<sup>1</sup>

Carriage return is always tested in two ways, by margin lever stop and again by a group mark word mark at the end of the write field. All fixed test patterns are 83 characters long. Because of the printout identification character (R normally) and the space that follows it, the first test pattern character is typed in position three and the last in position eighty-five if the tabs are set correctly. A carriage return and indexing operation is therefore initiated by both the B channel group mark word mark and an end of line condition. This produces a double space between each pair of lines of every test pattern. Look for this to occur.

00.3 EQUIPMENT

Any model 1410 or 7010 Data Processing System. The 1415 Console I/O Printer is the only I/O device tested. It is assumed to be on E channel only.

The Processing Overlap Feature is not necessary but is done in overlap mode if it is available.

00.4 CARD DECK

A complete card deck of WT01 consists of the following:

7 cards	Loader
1 card	Execute (Core Clear)
program cards <sup>2</sup>	Program WT01
1 card	Execute (branch to 02000)

Note: Card No. 001 is a System Control Card. It does not have any control information punched in it when it is released. See "1410/7010 Introduction," Volume 1.00, for instructions on how to punch it.

00.5 EC LEVEL OF MACHINE

Not applicable.

<sup>1</sup> Be sure to follow instructions on setting up margin lever stops as explained in OPERATING PROCEDURES, Section 5.00.02.1.

<sup>2</sup> See Release sheet for exact number of cards.

5.00.01.0 LOADING PROCEDURES

Use Standard Diagnostic Loading Procedure. Refer to "1410/7010 Introduction," Volume 1.00, for further information.

5.00.02.0 OPERATING PROCEDURES

02.1 Always set the right and left hand margin lever stops to their maximum right and left hand positions (0 and 85, respectively). The test patterns and the character position count both depend on this. A group of four-digit numbers separated by slashes occurs in one line of this test for counting purposes. The units position of each number corresponds to the position of the character with respect to the left-hand margin. The printout identification character R is counted as number one.

WT01 begins immediately on completion of loading and no manual intervention is required.

02.2 Test operation can be altered at any time by using the "Program Alter Routine." An Inquiry Request is acknowledged upon completion of any line of type. TADs are loaded as blanks and the locations are only tested for 1. TAD5, a Special TAD, is an exception and its use is described fully.

Standard TADs

<u>TADs</u>	<u>Address</u>	<u>Not 1</u>	<u>1</u>
TAD0	01000	Do Not	Bypass Typeouts
TAD1	01001	Do Not	Loop on Routine
TAD2	01002	Do Not	Halt on Error
TAD3	01003	Do Not	Repeat Test

Special TADs

TAD4	01004	Do Not	Typeout time to type 1 line
TAD5	01005	Do Not	Select Test Pattern by letter

TAD 0 is used only to bypass an error message typeout.

Setting TAD4 to a 1 causes a typeout of the time it took to type the line preceding it to be given. Use only on systems with the Processing Overlap Feature.



5.00.02.0 OPERATING PROCEDURES (continued)

Use TAD 5 to select a particular test pattern by name (actually by letter). If it remains a blank, all test routines are run in order. Entering the test pattern selection character (A, B, C, ...F) causes the test to go directly to the pattern selected. The test patterns and the letters that relate to them are covered in the description, Section 5.00.00.1. Entering an X causes the test to go to the "SELECTED CHARACTER ROUTINE." After entering an M or an L in response to "ENTER MODE- M OR L," the request "ENTER DATA FIELD" is made. At this time a full line of characters with or without word marks may be entered. If the number of characters entered is less than a full line (83), the portion entered is expanded to produce a full line typeout. To have less than a full line typed out, enter a group mark word mark after the last character to be typed. The line of characters is typed twice unless TAD1 is set to loop on routine. Entering a Z in TAD5 takes the program to the end of job message and into the next test.

5.00.03.0 OPERATING HINTS, COMMENTS

- 03.1 On systems equipped with overlap all test routines are typed in overlap mode. This makes it convenient to give typeouts of the length of time it takes to type a given line on request. If it is necessary to operate in unoverlap mode, reload the test, press STOP while "WT01" is being typed out, alter location 01263 to a blank, RESET and START. The test is started over from the beginning including the necessary initialization.

Should it ever be necessary to time (approximately) a carriage return operation instead of a normal line print operation, the following is offered. Use the SELECTED CHARACTER ROUTINE to type a simple line, preferably blanks (b's) in Load Mode or zeros (0's). Set TAD 1 to loop on routine (location 01001 to a 1) and TAD4 to a 1 for timing. With the right hand margin selector on 85 (end of line), take several lines of outputs. Now set the margin selector to 84. This causes a carriage return and the last character of the line to be typed in column 1. The time difference between the two lines is carriage return time (approximately).

1. Timing can only be used on systems with the Processing Overlap Feature.

5.00.03.0 OPERATING HINTS, COMMENTS

- 03.2 The time for one pass of WT01 including all test routines, titles, etc., but no timing typeouts or Inquiry Requests is approximately 4 minutes.
- 03.3 The SELECTED CHARACTER ROUTINE can be used to investigate the Output Error Routine by entering a group mark word mark for the data field. This causes an underscored zero (0) followed by underscored blanks (b) to be typed. All characters are typed in column 1. Once this operation is initiated, it is not under program control and STOP or RESET must be used to terminate it.

5.00.04.0 PROGRAM STOPS, RESTARTS

There are no Normal Stops in WT01 and only one Error Stop. It is under TAD control and occurs only if TAD 2 is set to 1. The STOP follows an error typeout indicating a data check error. Push START to continue the test.

RESET and START causes the test to begin again at 02000, repeating the typeout of the test identification and performing all the initialization.

5.00.05.0 TYPEOUTS

- 05.1 The only typeout that has not been explained in preceding sections or may need clarification is:

\*\*\* DATA CHECK IN LAST LINE TYPED \*\*\*

This message indicates that a parity check error (Data Check) occurred during the typing of the test line above it. The character or characters involved should be underscored.

5.00.02.0 OPERATING PROCEDURES (continued)

Use TAD 5 to select a particular test pattern by name (actually by letter). If it remains a blank, all test routines are run in order. Entering the test pattern selection character (A, B, C, ... F) causes the test to go directly to the pattern selected. The test patterns and the letters that relate to them are covered in the description, Section 5.00.00.1. Entering an X causes the test to go to the "SELECTED CHARACTER ROUTINE." After entering an M or an L in response to "ENTER MODE- M OR L," the request "ENTER DATA FIELD" is made. At this time a full line of characters with or without word marks may be entered. If the number of characters entered is less than a full line (83), the portion entered is expanded to produce a full line typeout. To have less than a full line typed out, enter a group mark word mark after the last character to be typed. The line of characters is typed twice unless TAD1 is set to loop on routine. Entering a Z in TAD5 takes the program to the end of job message and into the next test.

5.00.03.0 OPERATING HINTS, COMMENTS

- 03.1 On systems equipped with overlap all test routines are typed in overlap mode. This makes it convenient to give typeouts of the length of time it takes to type a given line on request. If for some reason it is necessary to operate in unoverlap mode once the test is in progress, alter location 01263 to a blank (location denotes overlap in System Control Card), RESET and START. The test is started over from the beginning including the necessary initialization.

Should it ever be necessary to time (approximately) a carriage return operation instead of a normal line print operation, the following is offered. Use the SELECTED CHARACTER ROUTINE to type a simple line, preferably blanks (b's) in Load Mode or zeros (0's). Set TAD 1 to loop on routine (location 01001 to a 1) and TAD4 to a 1 for timing. With the right hand margin selector on 85 (end of line), take several lines of outputs. Now set the margin selector to 84. This causes a carriage return and the last character of the line to be typed in column 1. The time difference between the two lines is carriage return time (approximately).

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APPENDIX

1415 CONSOLE PRINTER

TRANSLATOR, OUTPUT

<u>BCD Bits</u>	<u>Magnet Picked</u>
$\bar{2}$	R1
$\bar{8} \cdot 4$	R2
$\bar{8} + 4$	R2A
$8 \cdot \bar{1} + \bar{8} \cdot 1$	R5
$\bar{A}$	T1
$\bar{B}$	T2
$\bar{C}$	CK
$8 \cdot 4 \cdot 2 \cdot 1 + 8 \cdot 4$	UC
All others	LC
V (Word Mark)	UC · CK
_ (Underscore)	UC · CK · T1 · T2

TRANSLATOR, INPUT

<u>Contacts Transferred</u>	<u>BCD Bit</u>
$R5 \cdot \overline{R2A} \cdot LC + \overline{R5} \cdot R2A + \overline{R5} \cdot UC$	1
$R1 \cdot \overline{R2A} + LC \cdot R1$	2
$R2 \cdot \overline{R2A}$	4
$R2A \cdot LC + \overline{R2A} \cdot UC$	8
T1	A
T2	B
CK + Space	C
Word Mark	WM

Contracts transfer when corresponding magnet is NOT picked, except R5 which transfers when magnet is picked.

Keyboard to contact coding is same as magnets picked.

1415 CONSOLE PRINTER

Character	BCD Code	Magnets Picked																		
b (Blank)	C											R1	R2	R2A		T1	T2		UC	*
. (Period)		B	A	8	2	1													C	LC
Π )	C	B	A	8	4							R1		R2A	R5				UC	
[		B	A	8	4	1						R1		R2A					C	UC
<		B	A	8	4	2									R2A	R5			C	UC
≠ (Group Mark)	C	B	A	8	4	2	1								R2A				UC	
& (Ampersand) +	C	B	A									R1	R2	R2A					UC	*
\$	C	B		8	2	1											T1			LC
*		B		8	4							R1		R2A	R5	T1			C	UC
]	C	B		8	4	1						R1		R2A		T1			UC	
:	C	B		8	4	2									R2A	R5	T1		UC	
Δ		B		8	4	2	1								R2A		T1		C	UC
-		B										R1	R2	R2A		T1			C	UC
/	C	A				1						R1	R2	R2A	R5		T2		LC	*
, (Comma)	C	A	8	2	1												T2		LC	
% ( )		A	8	4								R1		R2A	R5		T2	C	UC	
~ (Wd Separator)	C	A	8	4	1							R1		R2A			T2		UC	
\	C	A	8	4	2										R2A	R5		T2	UC	
## Segment Mark		A	8	4	2	1									R2A		T2	C	UC	
Ⓢ Substitute		A										R1	R2	R2A			T2	C	UC	*
# Blank =			8	2	1												T1	T2	C	LC
@ ,	C		8	4								R1		R2A	R5	T1	T2		UC	
:			8	4	1							R1		R2A		T1	T2	C	UC	
>			8	4	2										R2A	R5	T1	T2	C	UC
∇ (Tape Mark)	C		8	4	2	1									R2A		T1	T2	UC	
?	C	B	A	8	2										R5				LC	
A		B	A			1						R1	R2	R2A	R5			C	LC	
B		B	A			2							R2	R2A				C	LC	
C	C	B	A			2	1						R2	R2A	R5				LC	
D		B	A			4						R1		R2A				C	LC	
E	C	B	A			4	1					R1		R2A	R5				LC	
F	C	B	A			4	2								R2A				LC	
G		B	A			4	2	1							R2A	R5			C	LC
H		B	A	8								R1			R5			C	LC	
I	C	B	A	8		1						R1							LC	
J		B		8	2										R5	T1		C	LC	
K	C	B				1						R1	R2	R2A	R5	T1			LC	
L	C	B				2							R2	R2A		T1			LC	
M		B				2	1						R2	R2A	R5	T1		C	LC	
N	C	B				4						R1		R2A		T1			LC	
O		B				4	1					R1		R2A	R5	T1		C	LC	
P						4	2								R2A		T1		C	LC
	C	B				4	2	1							R2A	R5	T1		LC	

\* From keyboard R5 selected instead of R1, R2, R2A.

1415 Console Printer (continued)

<u>Character</u>	<u>BCD Code</u>				<u>Magnets Picked</u>									
Q	C	B	8		R1			R5	T1					LC
R		B	8	1	R1				T1		C			LC
⚡ (Record Mark)		A	8	2				R5		T2	C			LC
S	C	A		2 1		R2	R2A	R5		T2				LC
T		A		2 1		R2	R2A	R5		T2	C			LC
U	C	A	4		R1		R2A			T2				LC
V		A	4	1	R1		R2A	R5		T2	C			LC
W		A	4	2			R2A			T2	C			LC
X	C	A	4	2 1			R2A	R5		T2				LC
Y	C	A	8		R1			R5		T2				LC
Z		A	8	1	R1					T2	C			LC
0	C		8	2				R5	T1	T2				LC
1				1	R1	R2	R2A	R5	T1	T2	C			LC
2				2		R2	R2A		T1	T2	C			LC
3	C			2 1		R2	R2A	R5	T1	T2				LC
4			4		R1		R2A		T1	T2	C			LC
5	C		4	1	R1		R2A	R5	T1	T2				LC
6	C		4	2			R2A		T1	T2				LC
7			4	2 1			R2A	R5	T1	T2	C			LC
8			8		R1			R5	T1	T2	C			LC
9	C		8	1	R1				T1	T2				LC
v (Word Mark)											C	UC		
_ (Underscore)									T1	T2	C	UC		





I/O PRINTER TEST

PGLIN	LABEL	OPCCD	OPERAND	CT	ADDR	INSTRUCTION
1002	LOADER	EQU	400			
1003						
1004	*	*****	STANDARD TADS	*****		
1005		ORG	1000		01000	
1006	*		NOT 1			
1007	TAD0	DC	2 2	DO NOT		1 01000
1008	TAD1		2 2	DO NOT		1 01001
1009	TAD2		2 2	DO NOT		1 01002
1010	TAD3		2 2	DO NOT		1 01003

\*TEST SET UP IN THE NOT 1 CONDITION\*  
AND WILL ONLY CHECK FOR A 1

\*\*\*\*\* SPECIAL TADS \*\*\*\*\*

1015	*	*****	SPECIAL TADS	*****		
1016						
1017	TAD4	DC	2 2	DO NOT		1 01004
1018						
1019	TAD5		2 2	DO NOT		1 01005
1020						

\* THE FOLLOWING MAY BE USED IN  
TADS TO SELECT TEST PATTERNS

- A TEST A COLLATING SEQUENCE
- B TEST B ROCKING EXERCISE
- C TEST C ROLLING EXERCISE
- D TEST D TWISTING EXERCISE
- E TEST E WORDMARK ALIGNMENT
- F TEST F BANDWIDTH-ALIGNMENT
- X TEST X SELECTED CHARACTERS
- Z THEEND EOJ MESSAGE & B 400

1021						
1022						
1023						
1024						
1025						
1026						
1027						
1028						
1029						
1030						
1031	GMW	DCW	2 2			1 01006

PG/LIN	LABEL	OPCODE	OPERAND	CT	ADDRS	INSTRUCTION
1033	*		*PROGRAM ALTER AND CONTROL ROUTINE			
1034						
1035	CONTRL	SBR	CTLXIT&S	7	01007	G 01081 B
1036	ENTER	RCP	ADDRESS&4	10	01014	M &T0 01049 R
1037		BNTI	CTLXIT Y	7	01024	R 01076 B
1038		BEXI	ENTER,M	7	01031	R 01014 M
1039		BAI	ADDRES	7	01038	R 01045 M
1040	ADDRES	RCPW	00000 S	10	01045	L &T0 00000 R
1041		BEXI	ADDRES,M	7	01055	R 01045 M
1042		BAI	*&I	7	01062	R 01069 M
1043						
1044		B	TSTSEL	7	01069	J 01083
1045						
1046	CTLXIT	B	00000	7	01076	J 00000
1047	*					
1048	*					
1049	*					
1050	TSTSEL	BCE	YESTA,TAD5,A	12	01083	B 02007 01005 A
1051		BCE	TESTB,TAD5,B	12	01095	B 02160 01005 B
1052		BCE	TESTC,TAD5,C	12	01107	B 02251 01005 C
1053		BCE	TESTD,TAD5,D	12	01119	B 02342 01005 D
1054		BCE	TESTE,TAD5,E	12	01131	B 02433 01005 E
1055		BCE	TESTF,TAD5,F	12	01143	B 02555 01005 F
1056		BCE	TESTX,TAD5,X	12	01155	B 02653 01005 X
1057		BCE	THEEND,TAD5,Z	12	01167	B 02993 01005 Z
1058		B	CTLXIT	7	01179	J 01076
1059	H		DEFINE PRECEDING BRANCH LENGTH	1	01186	.

PGLIN	LABEL	OPCCD	OPERAND	I/O PRINTER TEST	CT	ADRS	INSTRUCTION
1061		ORG	1230	CONTROL INFORMATION		01230	
1062		DC	a		15	01244	
1063		DC	255100a	SEQ# 551 SK SYS1 ONLY	5	01249	
1064	TESTID	DCW	2NT01a	*TEST IDENTIFICATION	4	01253	
1065	LEVEL	DC	28a.g		1	01254	
1066							
1067		ORG	1256	*SYSTEM CONTROL CARD		01256	
1068	SYS1	DC	a a	INDICATE SYSTEM TYPE	1	01256	
1069				0 1410 STD			
1070				I 1410 ACC			
1071				X 7010			
1072			a	NOT INTERROGATED	6	01262	
1073			a a	I-SYSTEM HAS OVERLAP	1	01263	
1074			a		15	01278	
1075			a	NOT INTERROGATED	10	01288	
1076		ORG	1289			01289	
1077							
1078				UTILITY TYPING AND SPACING ROUTINE			
1079							
1080	TYPEIT	SBR	TYPE88	STORE ADDRESS OF MESSAGE	7	01289	G 01304 B
1081	TYPE	WCP	00000	TYPE MESSAGE	10	01296	M 2T0 00000 M
1082		SBR	TYPEXT&5	STORE ADDRESS FOR RETURN	7	01306	G 01383 B
1083		BCB1	TYPE		7	01313	R 01296 Z
1084		BAL	*&1	CONTINUE	7	01320	R 01327 M
1085		CW	SPACE&1		6	01327	0 01358
1086	SPACE	SBR	SPACE&6	EXIT WHEN SPACING	7	01333	G 01363 B
1087		WCP	ABLANK	ONE BLANK LOCATION	10	01340	M 2T0 01385 M
1088		BAL	*-16		7	01350	R 01340 M
1089	SPACEX	NCPWA			1	01357	N
1090		B	00000	EXIT WHEN SPACING	7	01358	J 00000
1091		SW	SPACE&1		6	01365	0 01358
1092		BNQ	CONTR	TO CONTROL ROUTINE	7	01371	J 01007 Q
1093	TYPEXT	B	00000	EXIT WHEN TYPING SUBTITLES, ETC	7	01378	J 00000
1094							
1095	ABLANK	DCW	a a.g	JUST FOR A SPACE	1	01385	

PGLIN	LABEL	OPCOD	OPERAND	INITIALIZATION- DONE ON FIRST PASS ONLY	CT	ADDRS	INSTRUCTION
1097	*			INITIALIZATION- DONE ON FIRST PASS ONLY			
1098							
1099	SETUP	CS	99	CLEAR OUT TOP 100 ADDRESSES	6	01387	/ 00099
1100		MRCWG	B2000,1	SET UP RESET RESTART BRANCH AT 1	12	01393	D 01612 00001 L
1101		SW	95,25	SET WMS IN INDEX REGISTERS	11	01405	, 00095 00025
1102		MLWB	95,90	MOVE THEM ALL THE WAY THROUGH	12	01416	D 00095 00090 M
1103		ZA	OTIME,TIME	U SEC/PASS IN TIMING LOOP,1410	11	01428	M 01703 03587
1104		BCE	CK40LP,SYSL,0	SYSTEM IS STD 1410	12	01439	B 01485 01256 0
1105		ZA	ITIME,TIME	U SEC/PASS 1410 ACC	11	01451	M 01707 03587
1106		BCE	CK40LP,SYSL,I	SYSTEM IS 1410 ACC	12	01462	B 01485 01256 I
1107		ZA	XTIME,TIME	U SEC/PASS 7010	11	01474	M 01711 03587
1108	CK40LP	BCE	*E19,SYSL,E7,	CHECK FOR OVERLAP	12	01485	B 01515 01263
1109		SW	OVRLEP&1	SET UP FOR OVERLAP	6	01497	, 03209
1110		MLCS	@@@,TYPEP&1	TYPE IN OVERLAP MODE	12	01503	D 04436 03199 3
1111		SW	PATRX&84	SET ADDRESS	6	01515	, 04436
1112		SAR	ENDOFX	IN INDEX REGISTER	7	01521	G 00049 A
1113		SW	TWTGP&40	SETTING WORDMARK IN PATTERN	6	01528	, 04056
1114		SW	SPBSP1,SPBSP1&82	SET WMS IN TEST PATTERN	11	01534	, 04100 04182
1115		SW	SPBSP2,SPBSP2&82		11	01545	, 04184 04266
1116		MLWB	SPBSP1&82,SPBSP1&80	MOVE WMS OVER EVERY OTHER ONE	12	01556	D 04182 04180 M
1117		MLWB	SPBSP2&82,SPBSP2&81		12	01568	D 04266 04265 M
1118		MLCS	@@,ENTERX&9	SET UP READ CONSOLE PRINTER	12	01580	D 04437 02797 3
1119		B	TYPEIT		7	01592	J 01289
1120		DCW	@WT01B@,G		5	01603	
1121		B	TESTA	BEGIN TEST PATTERN SEQUENCE	7	01605	J 02007
1122							
1123	B2000	DCW	@JC2000 @,G	RESET RESTART	7	01612	
1124		ORG	*EX00			01700	
1125	OTIME	DCW	E0167	U SEC/PASS IN TIMING LOOP 1410	4	01703	
1126	ITIME		E0133	U SEC/PASS IN TIMING LOOP 1410I	4	01707	
1127	XTIME		E0047	U SEC/PASS IN TIMING LOOP 7010	4	01711	

PGLIN	LABEL	OPCODE	OPERAND	CT	ADDRS	INSTRUCTION
1129		ORG	2000		02000	
1130	START	B	SETUP	7	02000	J 01387
1131						
1132						
1133	TESTA	B	SPACE	7	02007	J 01333
1134		B	TYPEIT	7	02014	J 01289
1135		DCW	COLLATING SEQUENCE	40	02060	
1136						
1137	TYPEA	B	WCP	7	02062	J 03100
1138		DCW	CSGPI	5	02073	03596
1139		B	WCP	7	02074	J 03100
1140		DCW	CSGPI	5	02085	03596
1141						
1142		B	SPACE	7	02086	J 01333
1143		B	WCP	7	02093	J 03100
1144		DCW	CSGP2	5	02104	03680
1145		B	WCP	7	02105	J 03100
1146		DCW	CSGP2	5	02116	03680
1147						
1148		B	SPACE	7	02117	J 01333
1149		B	WCP	7	02124	J 03100
1150		DCW	CSGP3	5	02135	03764
1151		B	WCP	7	02136	J 03100
1152		DCW	CSGP3	5	02147	03764
1153						
1154		BCE	TYPEA,TA01.1	12	02148	B 02062 01001 1

REPEAT PATTERN A

REPEAT PATTERN A

I/O PRINTER TEST

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1156	TESTB	B	SPACE	7	02160	J 01333
1157		B	TYPEIT	7	02167	J 01289
1158		DCW	ARCCK	40	02213	
1159						B@,G
1160	TYPEB	B	WCPW	7	02215	J 03115
1161		DCW	ROKGP	5	02226	03848
1162		B	WCPW	7	02227	J 03115
1163		DCW	ROKGP	5	02238	03848
1164						
1165		BCE	TYPEB,TADI,1	12	02239	B 02215 01001 1
1166	*					
1167	*					*****
1168	*					
1169	TESTC	B	SPACE	7	02251	J 01333
1170		B	TYPEIT	7	02258	J 01289
1171		DCW	AROLL	40	02304	
1172						C@,G
1173	TYPEC	B	WCPW	7	02306	J 03115
1174		DCW	ROLGP	5	02317	03932
1175		B	WCPW	7	02318	J 03115
1176		DCW	ROLGP	5	02329	03932
1177						
1178		BCE	TYPEC,TADI,1	12	02330	B 02306 01001 1
1179	*					
1180	*					*****
1181	*					
1182	TESTD	B	SPACE	7	02342	J 01333
1183		B	TYPEIT	7	02349	J 01289
1184		DCW	ATWIST	40	02395	
1185						D@,G
1186	TYPED	B	WCPW	7	02397	J 03115
1187		DCW	TWIGP	5	02408	04016
1188		B	WCPW	7	02409	J 03115
1189		DCW	TWIGP	5	02420	04016
1190						
1191		BCE	TYPED,TADI,1	12	02421	B 02397 01001 1

I/O PRINTER TEST

PGLIN	LABEL	OPCOD	OPERAND	I/O PRINTER TEST	CT	ADDRS	INSTRUCTION
1193	TESTE	B	SPACE	SPACING ROUTINE	7	02433	J 01333
1194		B	TYPEIT	COMMON UTILITY TYPING ROUTINE	7	02440	J 01289
1195		DCW	QWM ALIGNMENT AND WM PERIOD TESTS	E3,G	40	02486	
1196							
1197	TYPEE	B	WCPW	TYPE TEST PATTERN IN LOAD MODE	7	02488	J 03115
1198		DCW	SPBSP1	SPACE AND BACKSPACE GROUP 1	5	02499	04100
1199		B	WCPW	TYPE TEST PATTERN IN LOAD MODE	7	02500	J 03115
1200		DCW	SPBSP1	SPACE AND BACKSPACE GROUP 1	5	02511	04100
1201							
1202		B	SPACE		7	02512	J 01333
1203		B	WCPW	TYPE TEST PATTERN IN LOAD MODE	7	02519	J 03115
1204		DCW	SPBSP2	SPACE AND BACKSPACE GROUP 2	5	02530	04184
1205		B	WCPW	TYPE TEST PATTERN IN LOAD MODE	7	02531	J 03115
1206		DCW	SPBSP2	SPACE AND BACKSPACE GROUP 2	5	02542	04184
1207							
1208		BCE	TYPEF,IAD1,1	REPEAT PATTERN E	12	02543	B 02488 01001 1
1209	*						
1210	*			*****			
1211	*						
1212	TESTF	B	SPACE		7	02555	J 01333
1213		B	TYPEIT		7	02562	J 01289
1214		DCW	BANDWIDTH & ALIGNMENT TEST	F3,G	40	02608	
1215							
1216	TYPEF	B	WCP		7	02610	J 03100
1217		DCW	BWAGP	BANDWIDTH AND ALIGNMENT GROUP	5	02621	04268
1218		B	WCP		7	02622	J 03100
1219		DCW	BWAGP	BANDWIDTH AND ALIGNMENT GROUP	5	02633	04268
1220							
1221		BCE	TYPEF,IAD1,1	REPEAT PATTERN F	12	02634	B 02610 01001 1
1222							
1223							
1224		B	THEEND	TEST X DONE ON REQUEST ONLY	7	02646	J 02993

I/O PRINTER TEST

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1226	TESTX	B	SPACE	7	02653	J 01333
1227		B	TYPEIT	7	02660	J 01289
1228		DCW	@SELECTED CHARACTER ROUTINE	40	02706	
1229						
1230		S	BUMPI	6	02708	S 00069
1231		B	TYPEIT	7	02714	J 01289
1232		DCW	@ENTER MODE-- M OR L@,G	18	02738	
1233		RCPW	MODE S	10	02740	L XTO 03419 R
1234		BEX1	*-16,M	7	02750	R 02740 M
1235		BAL	*@1	7	02757	R 02764 M
1236		B	TYPEIT	7	02764	J 01289
1237		DCW	@ENTER DATA FIELD@,G	16	02786	
1238	ENTERX	RCPW	PATRX	10	02788	L XTO 04352 R
1239						
1240		SBR	NEXT1	7	02798	G 00059 B
1241		BEX1	*-23,M	7	02805	R 02788 M
1242		BAL	*@1	7	02812	R 02819 M
1243		C	NEXT1,@PATRX	11	02819	C 00059 04442
1244		BE	TYPEX	7	02830	J 02914 S
1245		S	@1,NEXT1	11	02837	S 04443 00059
1246	CK4END	C	NEXT1,ENDOFX	11	02848	C 00059 00049
1247		BE	TYPEX	7	02859	J 02914 S
1248	EXPAND	MLCWS	PATRX@BUMPI,@NEXT1	12	02866	D 04LV2 00#MO 7
1249		SBR	NEXT1	7	02878	G 00059 B
1250		A	@1,BUMPI	11	02885	A 04443 00069
1251		A	@2,NEXT1	11	02896	A 04444 00059
1252		B	CK4END	7	02907	J 02848

ZERO INDEX REGS USED TO COUNT

ENTER MODE-- M OR L

ENTER AGAIN ON 1/2/4/8/A

ENTER CHARACTERS FOR PATTERN

ENTER GMM FOR SP-ORTY LINE

STORE ADDR OF LAST CHAR ENTERED@1

TRY AGAIN ON 1/2/4/8/A

SEE IF ANY ENTRY WAS MADE

NO TYPE OLD PATTERN

REDUCE B ADDR REG BY 1

CHECK FOR END OF PATTERN

OK TYPE IT

EXPAND TO FULL LINE

STORE ADDR OF LAST CHAR ENTERED@1

ADD TO COUNTERS

STEP TO NEXT LOCATION

SEE IF ITS ALL DONE



I/O PRINTER TEST

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDKS	INSTRUCTION
1254	TYPEX	BCE	LMODE,MODE,L	12	02914	B 02957 03419 L
1255		B	WCP	7	02926	J 03100
1256		DCW	PATRNX	5	02937	04352
1257		B	WCP	7	02938	J 03100
1258		DCW	PATRNX	5	02949	04352
1259		B	*625	7	02950	J 02981
1260						
1261	LMODE	B	WCPW	7	02957	J 03115
1262		DCW	PATRNX	5	02968	04352
1263		B	WCPW	7	02969	J 03115
1264		DCW	PATRNX	5	02980	04352
1265						
1266		BCE	TYPEX,TAD1,1	12	02981	B 02914 01001 1
1267						
1268						
1269						
1270	THEEND	B	TYPEIT	7	02993	J 01289
1271		DCW	3	48	03047	
1272		BNQ	CONTRL	7	03049	J 01007 Q
1273		BCE	TESTA,TAD3,1	12	03056	B 02007 01003 1
1274		B	LOADER	7	03068	J 00400
1275		H		1	03075	.
1276						
1277		ORG	*6X00			03100

\*\*\* END OF JOB \*\*\*2,G

ANY LAST REQUEST

REPEAT TEST-NO INITIALIZATION

ON TO NEXT PROGRAM

DEFINE PRECEDING BRANCH LENGTH

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PGLIN	LABEL	OPCCD	OPERAND	TEST PATTERN TYPING ROUTINE	CT	ADDRS	INSTRUCTION
1279	*			TEST PATTERN TYPING ROUTINE			
1280							
1281	WCP	SBR	DATA	STORE ADDRESS OF DATA PATTERN	7	03100	G 00039 B
1282		B	SETOP	SET UP TYPE INSTRUCTION MODE	7	03107	J 03130
1283		DCW	2M2	MOVE MODE	1	03114	
1284							
1285	WCPW	SBR	DATA	STORE ADDRESS OF TEST PATTERN	7	03115	G 00039 B
1286		B	SETOP	SET MODE OF TYPE INSTRUCTION	7	03122	J 03130
1287		DCW	2L2		1	03129	
1288							
1289	SETOP	SBR	*26	STORE M OR L OP CODE	7	03130	G 03142 B
1290		MLCHS	0, TYPETP	SET MODE IN TYPE INSTRUCTION	12	03137	D 00000 03198 7
1291		CH	6&DATA	SET ADDRESS	6	03149	000M6
1292		SAR	RETURN	FOR RETURN TO TEST ROUTINE	7	03155	G 00029 A
1293		S	TOTAL	ZERO TIMING COUNTER	6	03162	S 03595
1294		CS	BUFFER&82	CLEAR CUT OUTPUT ARFA	6	03168	/ 03582
1295		MLNA	4&DATA,*26	SET ADDRESS OF TEST PATTERN	12	03174	D 000M4 03191 /
1296		MRCWG	0, BUFFER	SET TEST PATTERN INTO OUTPUT AREA	12	03186	D 00000 03500 L
1297	TYPETP	WCPW	BUFFER	TYPE TEST PATTERN	10	03198	L %TO 03500 W
1298	OVRLAP	NOPWM			1	03208	N
1299		BOLI	TIMER		7	03209	J 03230 1
1300		BCB1	TYPETP		7	03216	R 03198 2
1301		B	CK4ERR		7	03223	J 03248
1302	TIMER	A	TIME,TOTAL	ADD LOOP TIME TO TOTAL	11	03230	A 03587 03595
1303		BOLI	*-17	RETURN WHILE OVERLAP IN PROCESS	7	03241	J 03230 1
1304	CK4ERR	BAL	ERRORT	BRANCH TO ERROR ROUTINE	7	03248	R 03328 M
1305		BCE	EDITIT, IAD4, 1	EDIT TIME FOR TYPEOUT	12	03255	B 03274 01004 1
1306		B	CK4INQ	NO TIME TYPEOUT	7	03267	J 03314
1307	EDITIT	MLCWA	CTLFLD, RESULT&4	PREPARE RESULT FIELD	12	03274	D 03425 03430 X
1308		MCE	TOTAL-4, RESULT&4	EDIT TOTAL FOR TYPING	11	03286	E 03591 03430
1309		WCP	RESULT	TOTAL TIME FOR ONE LINE	10	03297	M %TO 03426 W
1310		BAL	*-16		7	03307	R 03297 M
1311	CK4INQ	BNQ	CONTRL	TO CONTROL ROUTINE	7	03314	J 01007 0
1312		B	0&RETURN	RETURN TO TEST ROUTINE	7	03321	J 000+0

I/O PRINTER TEST

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1314	*		ERROR ROUTINE			
1315						
1316	ERROR	BCE	CK4HLT,TAD0,1	12	03328	B 03392 01000 1
1317		B	TYPEIT	7	03340	J 01289
1318		DCW	2*** DATA CHECK IN LAST LINE TYPED ***2,G	37	03383	
1319		8NQ	CONTRL	7	03385	J 01007 Q
1320	CK4HLT	BCE	HALT,TAD2,1	12	03392	B 03411 01002 1
1321		B	*E2	7	03404	J 03412
1322	HALT	H		1	03411	.
1323		B	CK4INQ	7	03412	J 03314
1324						
1325	*		RETURN TO TEST PATTERN TYPING			
1326						
1327	MODE	DCW	2 2,G	1	03419	MODE-M OR L
1328	CTLFLD	2	. 02	5	03425	EDIT CONTROL FIELD
1329	RESULT	2	. SECS2,G	10	03426	TIME TO TYPE 1 LINE OF TEST GROUP
1330						
1331		ORG	*EX00		03500	UP TO NEXT HIGHER CENTURY ADDRESS
1332	BUFFER	DA	1X83,G		03500	TYPE AREA
1333	TIME	DCW	80C00	4	03587	MICROSECONDS PER PASS IN ADD LOOP
1334	TOTAL		200000002	8	03595	TOTAL TIME

INSTRUCTION

CT

ADDRS

OPERAND

OPCOD

LABEL

PGLIN

PGLIN	LABEL	OPCOD	OPERAND	CT	ADDRS	INSTRUCTION
1336	*		TEST PATTERNS			
1337						
1338	CSGP1	DC	LL LL GG RR :: DD WM BB TT MM CC \$\$ ** BB :: LL -- // .. ** SS GG TT QQ SS MM NN /0085a,G	50	03596	
1339	CSGP2		AA BB CC DD EE FF GG HH II :: JJ KK LL MM NN OO PP QQ RR ** SS TT UU VV WW XX YY ZZa,G	33	03678	
1340				50	03680	
1341				33	03762	
1342	CSGP3		00 11 22 33 44 55 66 77 88 99 35 /0040/0045/0050/0a	50	03764	
1343				33	03846	
1344	ROKGP		IRZ96WOFDMU42SKBM.#08YQHGPX75VNECLT31/JAMMLM8Ba W S L RG B-ET;STa#.#.IRZ96WCFDMU42SKa,G BSWS T G LG	50	03848	TSDGLR
1345				33	03930	
1346	ROLGP		9642087531M: TazSBSM/TVXY+SUNZ.\$RCMK.QPNLJLB-;#ta LG T G LG	50	03932	DR .L
1347				33	04014	
1348	TWTGP		9642087531M: TazSBSM/TVXY+SUNZ.\$RCMK.QPNLJLB-;#ta LG T G LG	50	04016	L
1349				33	04098	
1350	SPBSP1		6FMD.M GTEaXN*V05T7SA.A.A.A.a,a,G D DDDD DDD	50	04100	DDD
1351				33	04182	
1352	SPBSP2		XXXX**WWW:::YYYY:::MMMIIIa,G DDD DDDD DDD	50	04184	::a
1353				33	04266	
1354	BWAGP		JJLJLQ.\$JJJJJJJJLJLQ.\$JJJJJJJJJJLJLQ.\$JJJJJJJJJJLJLQa	50	04268	
1355				33	04350	
1356	PATRX		JJLJLQ.\$JJJJJJJJLJLQ.\$JJJJJJJJJJLJLQ.\$JJa,G	50	04352	a
1357				33	04434	
1358						
1359	RETURN	EQU	1,X ADDR OF RETURN TO TEST ROUTINE			
1360	DATA	EQU	3,X ADDR OF DATA FIELD TO BE TYPED			
1361	ENDOFX	EQU	5,X ADDR OF END OF TEST X PATTERN			
1362	NEXT1	EQU	7,X ADDR REG USED IN TEST X EXPANSION			
1363	BUMPI	EQU	9,X COUNT TO EXPAND PATTERN IN TEST X			
1364						
1365	END		START			J02000
1365			aa	1	04436	
1365			aa	1	04437	
1365	PATRX			5	04442	04352
1365			61	1	04443	
1365			62	1	04444	

END OF ASSEMBLY